

Introducing IsSPICE4, a totally new version of SPICE. It is unlike anything you have run before. For years CAE tool developers have struggled to recreate the workbench on a computer. Now, with the advent of fast desktop PC's, this endeavor has been finally achieved by Intusoft. The new IsSPICE4 program is the first and only truly interactive version of SPICE.

IsSPICE4 is part of Intusoft's new ICAP Design Series. Two items give IsSPICE4 an

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Special Offer for the NEW ICAP/4 Windows, NT, or MAC

The ICAP/4Macintosh will be the first system available on Jan 18, 1994. ICAP/4 Windows and NT will be available April4, 1994. As a special limited time offer, customers that purchase any current ICAP/4 system between Dec. 6, 1993 and April 4, 1994, will receive the upgrade to the new version for FREE.

In This Issue New Interactive SPICE IsSPICE4 for Windows SPICE Benchmarks Modeling Sensors The Modeling Corner: New Asia-Pacific Parts

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New SPICE Goes Interactive

continued from page 33-1 unprecedented simulation advantage. First, the designer can <u>hand tweak</u> any circuit parameter, while the simulation is running, and watch the resulting waveform changes. It's like having your hand on a potentiometer and watching an oscilloscope at the bench. Second, with the SPICENET schematic entry tool, you can peek and poke at any node or component and see the simulated waveforms during or after the simulation has run. This probing occurs <u>directly on the schematic</u>. No window switching to a post processor is needed. If you are using another schematic entry tool don't worry, IsSPICE4 is going to be integrated into your schematic soon. In the meantime, your schematic outputs a SPICE netlist that IsSPICE4 can use, still allowing the interactive simulation features to be totally utilized.

IsSPICE4 gives you an added speed advantage. Because it runs continuously, you don't have to restart the program, re-read the input netlist, or perform a DC operating point. These features, along with the best 32-bit compilers and latest Berkeley SPICE code make IsSPICE4 the fastest SPICE simulator on the market. Benchmarks are shown in Table 1.

Real-Time Interactive Cross-Probing and Viewing

IsSPICE4 allows all waveforms to be viewed in real time. To view a node voltage simply click on the node with the new probing tool as shown in Figure 1. Clicking on a component causes the current in the component to be displayed. A new "save all allcur allpow" command allows all the voltages, currents, and device power dissipations to be available. Waveforms may be added to the IsSPICE4 display, shown in Figure 3, at any time.







Interactive Component Variation - Singly or In Groups

Virtually any circuit parameter can be varied directly from the schematic or the simulator. When the Interactive Stimulus tool is selected you can click on any device. The Stimulus dialog will be displayed with the component's value as shown in Figure 2 bottom left. A new value can be entered and a simulation automatically re-run. If the "Always" button is checked, the analysis will be immediately run as soon as the value is changed. If the mouse button is held down the parameter will be changed and a new analysis run as soon as the current analysis is finished. In this way, it is possible to control a circuit variable and watch the waveforms change. Any cross-probed waveforms on the schematic will be instantly updated in real time.

The Expression dialog, shown in Figure 2 bottom right, works in a manner similar to the Stimulus dialog. However, several circuit variables may be swept in tandem. The circuit parameters may be independent or functions of other variables. Using this dialog, curve families can be instantly built up in INTUSCOPE.



Figure 3, The IsSPICE4 simulation control dialog (left) allows you to interactively direct the flow of the simulation. The real time display (right) provides real-time access to all circuit waveforms.

Simulation Control Dialog - Figure 3

The Start, Pause, Resume, and Abort buttons are used to interactively control the IsSPICE4 simulation. Any of the powerful functions offered by IsSPICE4, such as Simulation Breakpoints or other analyses, may be typed into the script window and interactively executed. If you want a different transient analysis you don't have to restart the simulator. You just type in what you want and run it. The Script Atoms pop-up contains all of the available Interactive Command Language functions that can be used to build simulation scripts and test procedures. The Plots pop-up window is used to instantly recall waveforms from past simulations for comparison.

INTUSCOPE and New Model Libraries

INTUSCOPE has been upgraded as well. It <u>now uses extended</u> <u>memory to view large waveforms</u> and has access to all the waveforms from past or current simulations. Several scaling improvements have been made including: Linking of Y and X scales for all waveforms on a graph, tiling of waveforms, and a new algorithm for better offset calculations. The new ICAP systems include part libraries with over <u>5000 models</u>.

RISC vs. CISC, Caching, and Compilers

The tremendous speed increases brought about by the Pentium, Alpha and MIPS computers have enabled interactive SPICE simulation to become a reality. However, there still remains many obstacles to getting the most out of each machine. As we developed the Windows NT applications, it became evident that application speed was not increasing as fast as clock speed.

Our first encounter was with a 486/66 which ran large circuits no faster than a 486/33. As it turns out, SPICE places extraordinary demands on a computers' memory system when large circuits are simulated. The assumption that successive memory

SPICE Benchmark Runtimes

 Table 1, Partial list of the benchmark circuits used to test the speed and convergence of various SPICE programs. Index is compiled from a suite of 28 circuits. Long Index is based on LONG time only. (Times are in seconds)

Software Hardware	2G.6 Vax8700	IsSPICE4	ISSPICE4 MIPS/100	IsSPICE4	IsSPICE3	ISSPICE3	PSpice [®] /16	Number
Op. Sys.	VMS	NT	NT OF TOO	NT	DOS	DOS	DOS	Devices
Standard Be	nchmark (Circuits						
Diff. Pair	1.64	0.42	0.58	0.47	0.77	2.65	4.12	12
RCA3040	4.66	0.68	1.10	0.85	1.10	4.02	6.76	26
UA741	11.74	0.95	1.82	1.47	1.75	5.83	13.02	41
MECL Gate	3.61	0.50	0.87	0.75	0.87	2.97	5.05	35
DC Converg	DC Convergence Test Circuits							
Flip-Flop	0.20	0.05	0.07	0.05	0.05	0.33	0.55	17
74STTL	3.30	0.48	0.80	0.67	0.82	2.92	4.67	18
74LTTL	3.46	0.47	0.75	1.37	0.77	2.87	5.33	16
Transient Test Circuits								
Simple RC	0.49	0.20	0.15	0.13	0.17	0.93	0.93	4
ECL Gate	1.51	0.30	0.37	0.35	0.43	1.70	2.31	14
Schmitt Trig	1.95	0.32	0.43	0.38	0.48	1.92	2.80	15
Intusoft Gen	eral Test	Circuits						
SAMPLE	3.83	0.60	0.95	0.77	0.98	5.00	5.60	15
MOS Chain	4.93	1.48	3.23	2.47	2.57	8.47	17.68	12
Elliptic Filter	12.21	1.07	1.62	1.38	1.58	7.03	22.14	118
DIV/4	47.03	5.70	12.08	9.38	9.77	27.80	78.22	256
LONG	2311.40	329.52	760.70	498.32	506.90	1272.80	2854.72	2967
Index	.76	5.81	3.23	3.88	3.45	1.00	0.46	
Long Index	.55	3.86	1.67	2.55	2.51	1.00	0.45 PSpin trade	e is a registered mark of Microsim Corp.

accesses are to nearby address locations no longer holds. Interestingly, the same thing happens for programs written in object oriented languages. When memory access is over a large spread of address space, the cache system will eventually fail and data will have to be fetched from slower dynamic RAM.

In the case of the DEC Alpha running at 150 MHz, data access can be up to 20 times slower than its instruction execution rate. Moreover, we found that compilers for the newer machines were not executing standard library functions as fast as the compilers available for the older architectures. Math library functions are especially important for SPICE; however, almost all library functions ran a factor of 2 slower than the raw machine speed would indicate.

The conundrum for the "power" user - what computer is best is now exacerbated by the memory architecture, operating system, and compiler design. Our advice is be aware. Benchmark programs may not be a fair indication of the speed at which SPICE will run.

Modeling Sensors

The ability of IsSPICE to simulate mixed domain systems containing electrical, mechanical, physical, and mathematical elements is well documented. With behavioral models, Laplace functions, and a variety of electrical analogs as modeling tools, IsSPICE can lead to improved understanding of the interfaces between various domains. Simulations should be kept as simple as possible in order to limit run time and analysis complexity. Normally, it is recommended that devices that convert from a physical domain to an electrical domain be replaced by a signal generator. For instance, simulating the transfer function of a thermocouple (temperature in-voltage out) is not necessary unless the output of the system is a temperature that is destined to be feed back as an input to the thermocouple. A piece-wise linear voltage source would simply be used to emulate the output voltage of the thermocouple and eliminate the transfer function. In many applications, however, sensors are required to convert from one domain to the electrical domain and the transfer function is of great interest. In this application note we will explore how both pressure and Hall effect sensors can be modeled and show some example applications of simple mixed domain systems.

IC fabrication technology and traditional sensing mechanisms have been combined to create reliable, high performance sensors. For instance, advances in semiconductor materials and processing, have produced materials with high Hall coefficients that generate Hall voltages orders of magnitude higher than those produced with earlier materials. For applications





where pressure must be measured, mechanical switches are the most prevalent. However, for applications where reliability is a major concern, piezoresistive sensors offer a distinct advantage.

Pressure Transducers

Vs (1-4)

R(1+∆) VO

 $R(1+\Delta)$

R(1-∆) A pressure transducer is simply a nonlinear resistive bridge as shown left. They are fabricated as ion implanted resistors in a simple bridge configuration using common silicon processing techniques. When pressure is applied to the device, the

resistors change by an amount Δ producing an output voltage described by the following equation;

 $Vo = S * P * Vs \pm Vos$

where S is the sensitivity of the transducer, typically in mv/V/psi, P is the input pressure in psi, Vs is the supply voltage, and Vos is the zero pressure offset voltage at 25°C. The generic subcircuit shown in Figure 4 describes the simple linear behavior of a pressure transducer. The IsSPICE3 behavioral sources, B1 and B2, construct the output voltage equation. The sensitivity, SENS, and the zero pressure offset voltage, VOS, parameters are passed into the subcircuit and evaluated automatically when a simulation is run. The pressure, P1 - P2, is an input to the subcircuit as is the supply voltage, V(6) - V(5). The resistance, RIN, models the resistive bridge seen by the supply voltage and load. The sensitivity units are assumed to be V/V/ psi but can be altered as long as a consistent set is maintained throughout the subcircuit and the input voltage (analog of pressure) is specified correctly.

All of the generic parameters are available from a typical data sheet. For example, the SX01 pressure sensor from SenSym has the following typical characteristics;

ParametersSensitivity = 4 mV/V/psiZero Pressure VOS = 20mVmeasured at 25°CInput Resistance = $4.65k\Omega$ Output Resistance = $4.65k\Omega$

Thus, a typical call line to the generic model would be:

X1 1 2 3 4 DUCER {SENS=4E-3 VOS=-20E-3 RIN=4.65K ROUT=4.65K}

There are three kinds of sensors that can be modeled with the new subcircuit. Differential devices measure one pressure with respect to another pressure. P1 is typically the high pressure input with P2 the low. For the differential transducer model shown in Figure 4, P1 should always remain above P2. Gage devices measure pressure with respect to an ambient pressure. In this case, pressure is measured at one input while the other is set at a desired reference pressure. Absolute devices



measure pressure with respect to an internally isolated vacuum chamber. For these devices, the P2 pressure terminal is removed and replaced internally with a DC voltage source of 0.0005V representing 0.0005 psia. This will have to be adjusted if other units are used.

A typical application is shown in Figure 5. The SenSym SPX50 is used to produce a simple low cost oil filter monitor. The sensor monitors the pressure drop across a typical oil filter to determine its replacement status. A clean filter would typically have a 4 psid pressure drop, however, as dirt accumulates, the pressure drop across the filter increases. At a drop of 7psid, the filter should be changed. Slight modifications to the SP05 model were made to allow for topological differences in the SPX50 used above. During the simulation the pressure was swept from 0-10psi with resulting output at node 1 of .36mV to 1.2V. The output of the sensor went from 0 to 80mV over the 10psi range. Note: the sensor offset pot, RPOT, and the full-scale gain adjust resistor, R11, were both interactively tweaked to find their proper values without ever leaving the IsSPICE4 simulator.

Model Limitations

Generally, a sensor is operated in a specific pressure range. Since this range is not normally exceeded, some of the nonlinearities have not been modeled. The pressure transducer models the linear behavior of a given device. The model gives the correct response time through the use of delay elements. (R7,C1,E1 and R8,C2,E2 as seen in the subcircuit). Nonlinearities associated with the pressure to voltage conversion, hysteresis, repeatability, and stability are not modeled. Temperature dependencies (offset/span) are also not modeled but could be easily added. The applied pressure is not limited, hence, if the applied pressure exceeds the rated Maximum Over Pressure the transducer will operate as if it were a legal condition.

Other techniques for the development of new pressure transducers, such as the X-DucerTM made by Motorola, use a single piezoresistive element to sense the sheer stresses. This singleelement transverse voltage strain gauge can be viewed as the mechanical analog of a Hall effect device discussed next.

Hall Effect Sensors

Edwin H. Hall discovered in 1879 that a magnetic field would skew equipotential lines in a current carrying conductor. This effect is observed as a voltage perpendicular to the direction of the current in the conductor, hence the name "Hall effect". A Hall generator is a 4 terminal device that produces a voltage, V_{Hall} , proportional to the product of the input current, Ic, the magnetic flux density, B, and the sine of the angle between B and the Hall generator ($V_{Hall} = K * Ic * B$). By holding Ic constant, V_{Hall} becomes a direct function of B. If both IC and B are variable, V_{Hall} is proportional to the product of the two functions. With B and IC held constant, V_{Hall} becomes a function of the angle between B and the plane of the Hall sensor's active area.

SPICE modeling is an extremely powerful tool for predicting the performance of analog circuits that utilize Hall sensors, as well as for testing the operation of different sensors. The IsSPICE subcircuit used here was provided by F. W. BELL, makers of Hall generators. Table 2, at the end of the article, shows an example subcircuit. The subcircuit models the following effects:

nput Resistance	Output Resistance	Magneto Resistance
Magnetic Sensitivity	Inductive Pickup	Linearity
Offset Voltage	Temp. Coefficient of t	he Offset and the Output

Max., min., and typical models are available. The parameters that are altered in these models are the input resistance, output resistance, and sensitivity. All temperature coefficients and the misalignment voltage are set to their maximum values. All other parameters are set to their nominal values.

To test the Hall model, a current monitoring circuit was set-up. In the real circuit, the Hall sensor resides in a small gap in a fluxcollector toroid in order to measure the current. For the simulation, the Intusoft core model conveniently provides a flux test



point out of the nonlinear core model. The B1 element converts the flux into a current (IB=V(17)*Bm/Vn), where Bm and Vn are core model parameters. The current into the sensor (B+ - B-) represents the magnetic field level with 1A = 1KGauss. The circuit was simulated with the core saturated and unsaturated. The results are shown in Figures 6 and 7. Over 30 SPICE models of pressure and Hall effect sensors are included on the newsletter subscriber's floppy disk.

[1] SensSym Solid-State Sensor Handbook 1992, SensSym Inc., 1244 Reamwood Ave. Sunnyvale, CA 94089, 408-744-1500

[2] Motorola Master Selection Guide, Sensors section, 1992

[3] F.W. Bell Hall Generators Catalog, 6120 Hanging Moss Rd., Orlando FL 32807, 407-678-6900



[4] EDN Design Ideas Special Issue, Vol. 1 July 7, 1988, pg. 39



Table 2, IsSPICE3 subcircuit model for the E	3H200 Hall Effect sensor from F.W. Bell
Inc. The syntax uses SPICE3 conventions	to take advantage of the resistor mode
statement, For SPICE2 programs, move th	e resistor temperature coefficients on to
the register coll line "PCLIO 41 100 1 TC.	$-1 \equiv 0$ "
The resistor call line, RG00 41 100 1 10 1	= 1.E-2 .
.SUBCKT BH200 2 100 17 4 31 101	HGI2 64 70 VIB -1
* Node 2: +Ic Hall Control(Bias) Current Input	.MODEL TYPE2 NMOS LEVEL=1 VTO=3.148
* Node 100: -Ic Hall Control(Bias) Current Input	RMAGI 70 100 1 RMOD1 5M
* Node 17: +Vh Hall Output	.MODEL RMOD1_5M R(TC1= 1.5E-3)
* Node 4: -Vh Hall Output	HIST 71 100 VIST 1
* Node 31: +B Magnetic Field Input	RIST 71 100 1
* Node 101: -B Magnetic Field Input	EV1 7 6 POLY(2) 71 100 70 100 0 0 0 0 -0.5
FUO 100 41 VIST 1.E-3	EV2 8 100 POLY(2) 71 100 70 100 0 0 0 0 -0.5
RGUO 41 100 1 RMOD10M	HRO1 93 100 POLY(1) VIB -0.24846 0.109796
.MODEL RMOD10M R(TC1 = 1.E-2)	MO1 93 95 80 80 TYPE3
EUO 9 5 41 100 1	HGO1 95 80 VIB 1
E1 3 11 50 100 0.05	.MODEL TYPE3 NMOS LEVEL=1 VTO=2.2629
E2 13 4 50 100 0.05	HRO2 94 100 POLY(1) VIB -0.24709 -0.10988
VISI 270	
ENON 100 100 POLV(1) VIB 0.6 38E-5.0 7 465E-8	
RG 190 100 1 RMOD80011	INODEL 117E4 INNOS LEVEL=1 V10=2.2487
MODEL RMOD800U $R(TC1 = -8 E-4)$	
EMAGC 37 100 31 1 1 E3	ROM 81 100 1
CMAG 37 38 1.E-11	EV3 11 10 POLY(2) 81 100 80 100 0 0 0 0 -0 5
RMAG 38 100 4.695	EV4 12 13 POLY(2) 81 100 80 100 0 0 0 0 -0.5
EXX1 301 100 POLY(2) 71 100 190 100 0 0 0 0 10.0	R1 6 5 1 RMOD1 5M
EXX2 302 301 38 100 1	R2 5 8 1 RMOD1 5M
RXX1 302 100 1	R3 10 9 0.85 RMOD1 5M
ENON 17 15 302 100 1	R4 5 12 0.85 RMOD1_5M
HRI1 73 100 POLY(1) VIB -0.33862 0.108319	RB 31 1 1
MI1 73 63 70 70 TYPE1	VIB 1 101 0
HGI1 63 70 VIB 1	RDUM 101 100 1.E8
.MODEL TYPE1 NMOS LEVEL=1 VTO=3.126	GFST 100 50 POLY(2) 31 1 71 100 0 0 0 0 1
HRI2 74 100 POLY(1) VIB -0.34121 -0.10838	RST 50 100 1 RMOD800U
MI2 74 64 70 70 TYPE2	.ENDS

Intusoft NEWS: CompuServe Information Service

Intusoft maintains a bulletin board service under the CADD/ CAM/CAE Vendor forum on CompuServe. A variety of technical articles, application notes, demos and free SPICE models are posted there. To connect with Intusoft you can navigate through CompuServe's computing support menus to reach the CADD/CAM/CAE Vendor forum or type "Go CADDVEN" at any ! point prompt. Then select the "All CADD/CAM/CAE" section.

New items posted this month include: **Multidec** (a utility to create SPICE models of multiple coupled lossy transmission lines), SPICE models from Philips Semiconductors for ALS, FAST, and ABT logic families, plus a paper on SPICE models for fuses.

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+ VAR=20 IKR=60M RE=.63 RB=2.52 RC=.252 XTB=1.5 CJE=13.2P VJE=1.1 MJE=.5 CJC=4.26P + VJC=.3 MJC=.3 TF=795P TR=552N) ;Toshiba 2SC2705 150V 50mA 200MHz NPN BJT SUBCKT Q2SC2366 1 2 3 ; Fujitsu 400V 40A NPN Power BJT

Sample Pacific **Rim Models**

RBS 24 5 .MODEL QPWR NPN (IS=1.47P NF=1 BF=58.5 VAF=360 IKF=13.3 ISE=3.11N NE=2 + BR=4 NR=1 VAR=20 IKR=20 RF=11 5M RB=46 3M RC=4 63M XTB=1 5 + CJE=2.03N VJE=.6 MJE=.3 CJC=1.31N VJC=.22 MJC=.2 TF=10.6N TR=6.8U)

.ENDS

Q1 1 2 3 QPWR .67 Q2 1 4 3 QPWR .33

MODEL Q2SB767 PNP (IS=50.7F NF=1 BF=403 VAF=161 IKF=.3 ISE=12.5P NE=2 BR=4 NR=1 + VAR=16 IKR=.45 RE=78.3M RB=.313 RC=31.3M XTB=1.5 CJE=183P VJE=1.1 MJE=.5 CJC=59.1P + VJC=.3 MJC=.3 TF=1.32N TR=921N) ; Matsushita 80V .5A 120M PNP BJT

Stimulating Circuits: Variable Phase

The SIN wave generator in Berkeley SPICE does not have a phase delay, only an initial time delay. A simple way to create

* NODE 2 is the delayed Sine wave output for a phase * NODE 4 is a reference Sine wave voltage genue * NODE 10 is phase angle variation in degrees subcircuit us * VGEN is the amplitude in volts, FREQ is frequency in Hz of the 3 phase C1 10 {1/(6.28319K * FREQ)}; Use IC={VGEN} for UIC model includ R1 10 1 PULSE {VGEN * 1U} 0 ilbraries. Fir 11 0 1 PULSE {VGEN * 1U} 0 libraries. Fir \$11 0 1 0 41M get a cosine BE2 2 0 V={VOFFSET} + (V(5) * SIN(V(10) * 3.1415926/180) + the two are + V(4) * COS(V(10) * 3.1415926/180)) using the in- R5 4 4 0 1MEG in BE2. V(10 V1 4 0 SIN 0 {VGEN} {FREQ} voltage equation LENDS desired phase	merator. The uses a variation nase generator uded with standard model "irst a reference is integrated to ne wave. Then, e combined in-line equation 10) is the gual to the nase delay.
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a variable phase stimulus is to combine cosine and sine waveforms. The subcircuit in Figure 8 does this very efficiently using the IsSPICE3 in-line equation feature. To test the operation, the source was connected to a phase detector as shown in Figure 9. The stimulus waveform was modulated through several phase changes and the output of the detector observed.

Philips Produces Models for 3V BiCMOS

Philips has released SPICE models for its 3-Volt line of BiCMOS and MOS products including the HLL, LVC, and LVT families. The new models join previously released models for the ALS, FAST, and ABT logic families.